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106	APPLICANT: Jun-ichi Hashimoto, et al.			
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U.S. PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE, IF APPROPRIATE
MC	AA	2002/0168153	11/14/02	Yamabayashi, et al.			Copending application
	AB						
	AC						

FOREIGN PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
	AD							
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EXAMINER:			DATE CONSIDERED:			
M Coll		del	12/5/2005			
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